## Notice of References Cited Application/Control No. 09/749,430 Examiner Yuwen Pan Applicant(s)/Patent Under Reexamination SAURIOL ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,728,531	04-2004	Lee et al.	455/419
	В	US-		·	
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
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	7	US-			
	К	US-			
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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